

**Notice of References Cited**

Application/Control No.

09/889,687

Applicant(s)/Patent Under  
Reexamination  
DEKANY ET AL.

Examiner

Devesh Khare

Art Unit

1623

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,538,117	03-2003	Wong et al.	536/18.5
	B	US-6,040,433	03-2000	Kahne et al.	536/4.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 578,112	01-1994	Europe	Yamada et al.	<del>536/18.5</del>
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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